## Notice of References Cited Application/Control No. 09/975,895 Examiner David E. England Applicant(s)/Patent Under Reexamination PENK ET AL. Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,889,385 B1	05-2005	Rakib et al.	725/119
*	В	US-6,813,639 B2	11-2004	Nobakht et al.	709/227
*	С	US-5,913,039 A	06-1999	Nakamura et al.	709/231
*	D	US-6,928,656 B1	08-2005	Addington, Timothy Hall	725/111
*	Е	US-6,986,157 B1	01-2006	Fijolek et al.	725/111
*	F	US-5,809,204 A	09-1998	Young et al.	386/83
*	G	US-6,292,836 B1	09-2001	Teraoka, Fumio	709/236
*	Н	US-6,745,223 B1	06-2004	Nobakht et al.	709/200
*	ł	US-6,801,947 B1	10-2004	Li, Fulu	709/231
*	J	US-6,226,272 B1	05-2001	Okano et al.	370/259
*	К	US-5,790,935	08-1998	Payton, David W.	725/91
	٦	US-			
	М	US-		·	

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Ρ					
	α					
	R					
	S					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	v	
	w	
	х	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.



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